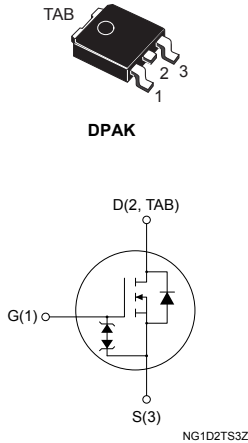



Automotive-grade N-channel 600 V, 380 mΩ typ., 10 A MDmesh DM2 Power MOSFET in a DPAK package


Product status link
[STD12N60DM2AG](#)
Product summary

| | |
|-------------------|---------------|
| Order code | STD12N60DM2AG |
| Marking | 12N60DM2 |
| Package | DPAK |
| Packing | Tape and reel |

Features

| Order code | $V_{DS} @ T_J \text{ max.}$ | $R_{DS(on)} \text{ max.}$ | I_D |
|---------------|-----------------------------|---------------------------|-------|
| STD12N60DM2AG | 650 V | 430 mΩ | 10 A |

- AEC-Q101 qualified 
- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

- Switching applications

Description

This high-voltage N-channel Power MOSFET is part of the MDmesh DM2 fast-recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{DS(on)}$, rendering it suitable for the most demanding high-efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|---|------------|------------------|
| V_{GS} | Gate-source voltage | ± 25 | V |
| I_D | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$ | 10 | A |
| | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 6.3 | |
| $I_{DM}^{(1)}$ | Drain current (pulsed) | 25 | A |
| P_{TOT} | Total power dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 110 | W |
| $dv/dt^{(2)}$ | Peak diode recovery voltage slope | 50 | V/ns |
| $dv/dt^{(3)}$ | MOSFET dv/dt ruggedness | 50 | |
| T_{stg} | Storage temperature range | -55 to 150 | $^\circ\text{C}$ |
| T_j | Operating junction temperature range | | |

1. Pulse width is limited by safe operating area.
2. $I_{SD} \leq 10\text{ A}$, $di/dt = 800\text{ A}/\mu\text{s}$; $V_{DS}(\text{peak}) < V_{(BR)DSS}$, $V_{DD} = 400\text{ V}$
3. $V_{DS} \leq 480\text{ V}$.

Table 2. Thermal data

| Symbol | Parameter | Value | Unit |
|------------------|---|-------|---------------------------|
| R_{thJC} | Thermal resistance junction-to-case | 1.14 | $^\circ\text{C}/\text{W}$ |
| $R_{thJA}^{(1)}$ | Thermal resistance, junction-to-ambient | 50 | |

1. When mounted on 1 inch² FR-4 board, 2oz Cu.

Table 3. Avalanche characteristics

| Symbol | Parameter | Value | Unit |
|----------------|---|-------|------|
| $I_{AR}^{(1)}$ | Avalanche current, repetitive or not repetitive | 2 | A |
| $E_{AS}^{(2)}$ | Single pulse avalanche energy | 250 | mJ |

1. pulse width limited by T_{jmax}
2. starting $T_j = 25\text{ }^\circ\text{C}$, $I_D = I_{AR}$, $V_{DD} = 50\text{ V}$.

2 Electrical characteristics

($T_C = 25\text{ °C}$ unless otherwise specified)

Table 4. Static

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|-----------------------------------|---|------|------|---------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0\text{ V}$, $I_D = 1\text{ mA}$ | 600 | | | V |
| I_{DSS} | Zero gate voltage drain current | $V_{GS} = 0\text{ V}$, $V_{DS} = 600\text{ V}$ | | | 1 | μA |
| | | $V_{GS} = 0\text{ V}$, $V_{DS} = 600\text{ V}$, $T_C = 125\text{ °C}^{(1)}$ | | | 100 | |
| I_{GSS} | Gate-body leakage current | $V_{DS} = 0\text{ V}$, $V_{GS} = \pm 25\text{ V}$ | | | ± 5 | μA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$ | 3 | 4 | 5 | V |
| $R_{DS(on)}$ | Static drain-source on-resistance | $V_{GS} = 10\text{ V}$, $I_D = 5\text{ A}$ | | 380 | 430 | m Ω |

1. Specified by design, not tested in production.

Table 5. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------------|-------------------------------|--|------|------|------|-------------|
| C_{iss} | Input capacitance | $V_{DS} = 100\text{ V}$, $f = 1\text{ MHz}$, $V_{GS} = 0\text{ V}$ | - | 614 | - | pF |
| C_{oss} | Output capacitance | | - | 32 | - | |
| C_{rss} | Reverse transfer capacitance | | - | 3.7 | - | |
| $C_{oss\text{ eq.}}^{(1)}$ | Equivalent output capacitance | $V_{DS} = 0\text{ to }480\text{ V}$, $V_{GS} = 0\text{ V}$ | - | 57 | - | pF |
| R_G | Intrinsic gate resistance | $f = 1\text{ MHz}$, $I_D = 0\text{ A}$ | - | 7 | - | Ω |
| Q_g | Total gate charge | $V_{DD} = 480\text{ V}$, $I_D = 10\text{ A}$, $V_{GS} = 0\text{ to }10\text{ V}$ (see Figure 14. Test circuit for gate charge behavior) | - | 14.5 | - | nC |
| Q_{gs} | Gate-source charge | | - | 3.8 | - | |
| Q_{gd} | Gate-drain charge | | - | 6.2 | - | |

1. $C_{oss\text{ eq.}}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Table 6. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|---|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 300\text{ V}$, $I_D = 5\text{ A}$, $R_G = 4.7\text{ }\Omega$, $V_{GS} = 10\text{ V}$ | - | 11 | - | ns |
| t_r | Rise time | | - | 8 | - | |
| $t_{d(off)}$ | Turn-off delay time | (see Figure 13. Test circuit for resistive load switching times and Figure 18. Switching time waveform) | - | 25 | - | |
| t_f | Fall time | | - | 13 | - | |

Table 7. Source-drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|---|------|------|------|------|
| I_{SD} | Source-drain current | | - | | 10 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 25 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $V_{GS} = 0\text{ V}$, $I_{SD} = 10\text{ A}$ | - | | 1.6 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 10\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, | - | 80 | | ns |
| Q_{rr} | Reverse recovery charge | $V_{DD} = 60\text{ V}$ | - | 250 | | nC |
| I_{RRM} | Reverse recovery current | (see Figure 15. Test circuit for inductive load switching and diode recovery times) | - | 5.0 | | A |
| t_{rr} | Reverse recovery time | $I_{SD} = 10\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, | - | 213 | | ns |
| Q_{rr} | Reverse recovery charge | $V_{DD} = 60\text{ V}$, $T_J = 150\text{ }^\circ\text{C}$ | - | 1072 | | nC |
| I_{RRM} | Reverse recovery current | (see Figure 15. Test circuit for inductive load switching and diode recovery times) | - | 7.8 | | A |

1. Pulse width is limited by safe operating area.
2. Pulse test: pulse duration = 300 μs , duty cycle 1.5%.

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

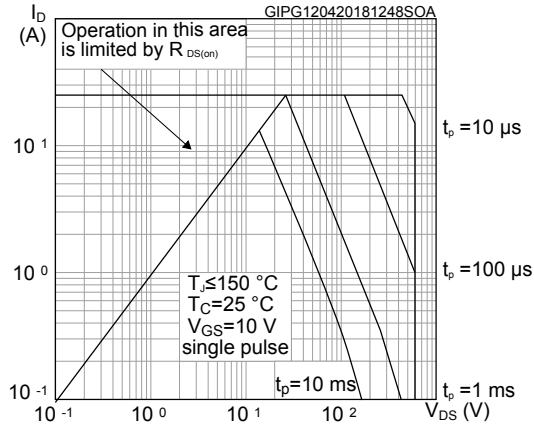


Figure 2. Normalized transient thermal impedance

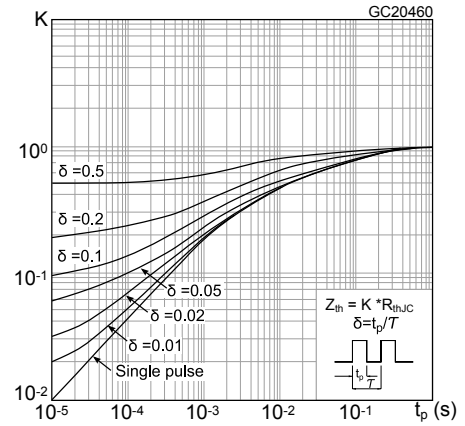


Figure 3. Typical output characteristics

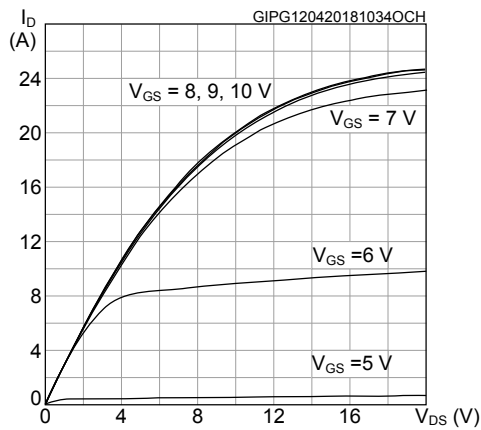


Figure 4. Typical transfer characteristics

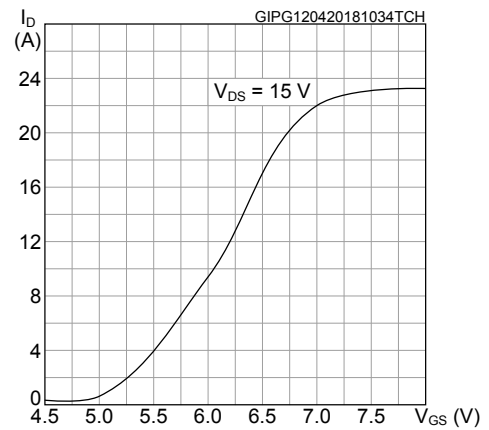


Figure 5. Typical gate charge characteristics

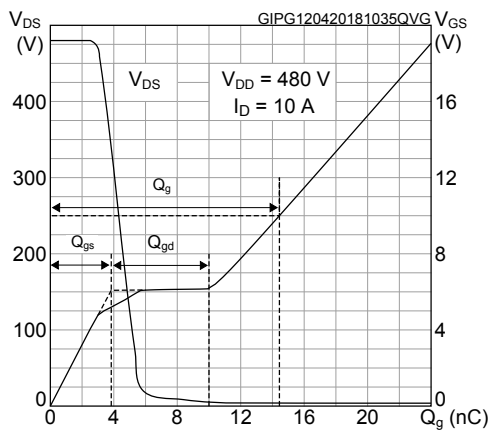


Figure 6. Typical drain-source on-resistance

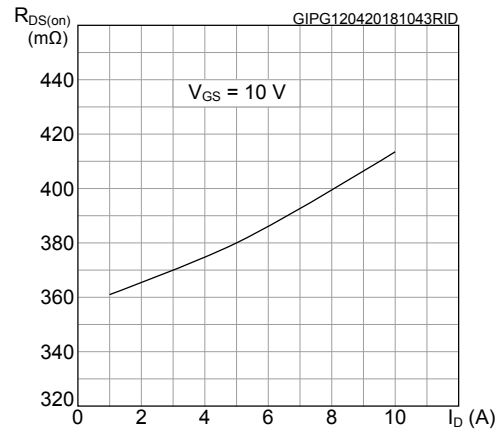


Figure 7. Typical capacitance characteristics

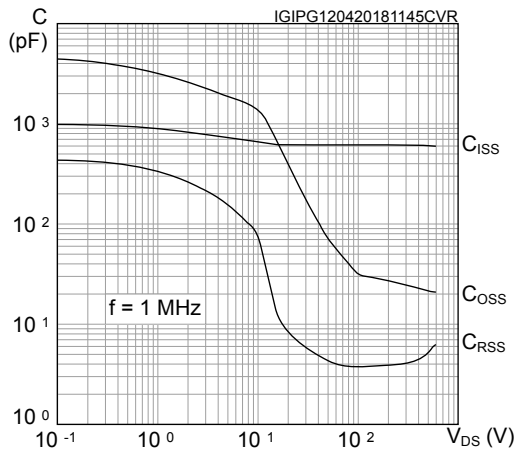


Figure 8. Normalized gate threshold vs temperature

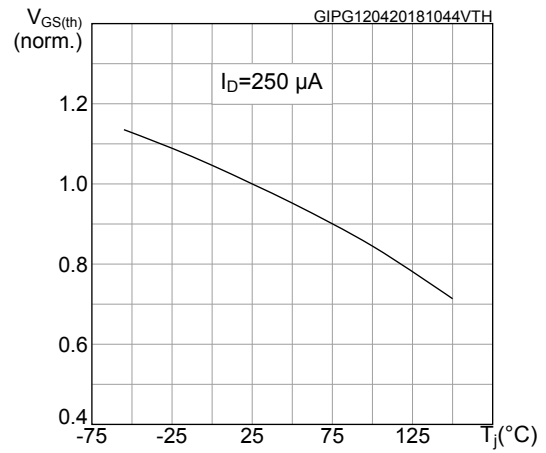


Figure 9. Normalized on-resistance vs temperature

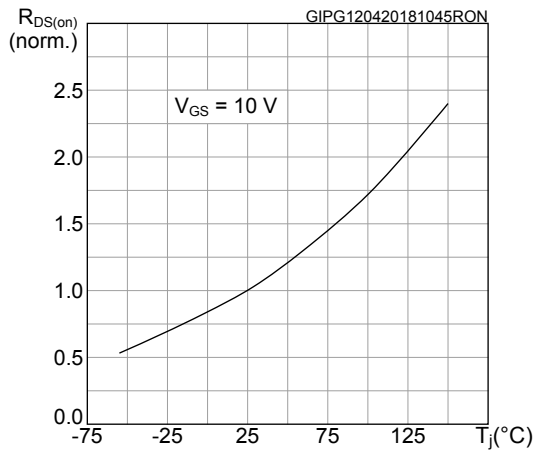


Figure 10. Normalized breakdown voltage vs temperature

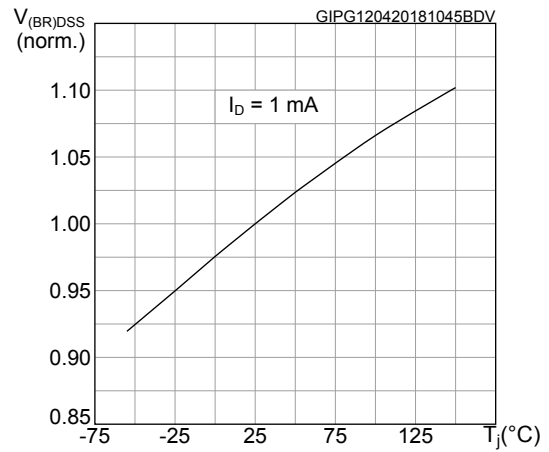


Figure 11. Typical output capacitance stored energy

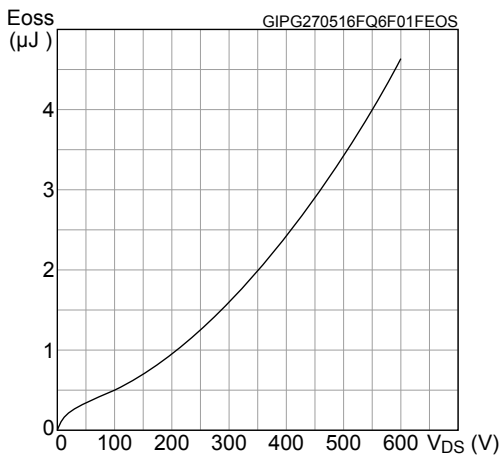
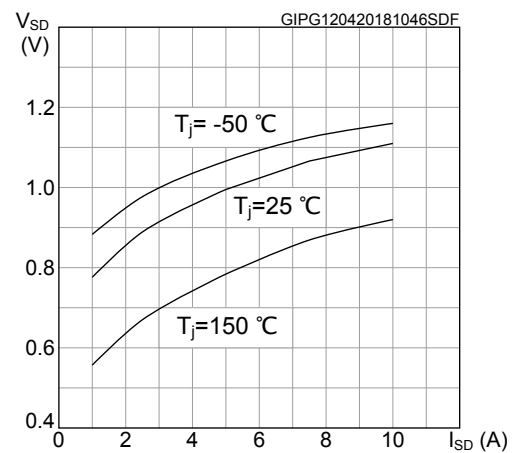
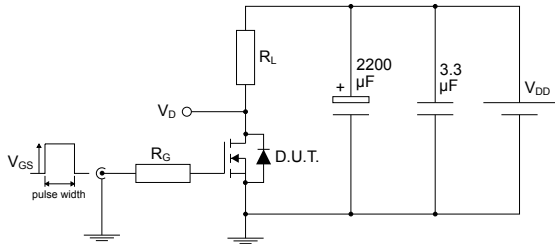


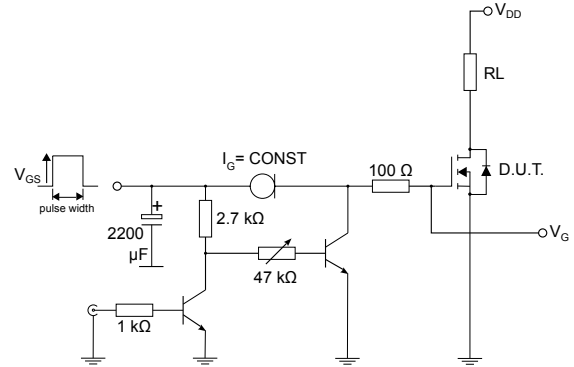
Figure 12. Typical reverse diode forward characteristics



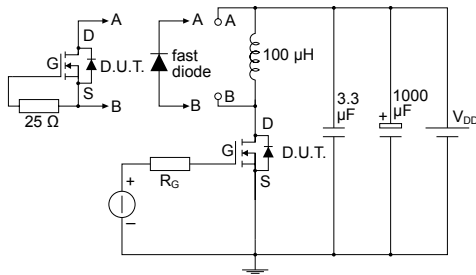
3 Test circuits

Figure 13. Test circuit for resistive load switching times


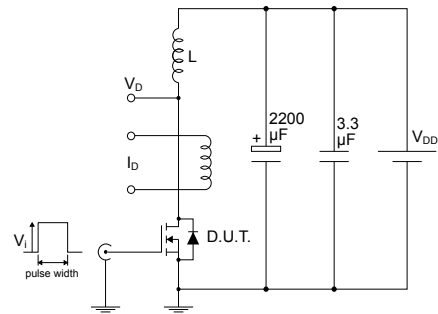
AM01468v1

Figure 14. Test circuit for gate charge behavior


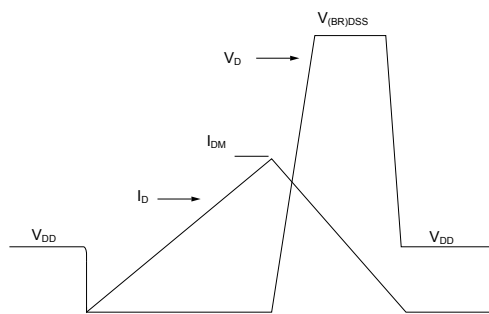
AM01469v10

Figure 15. Test circuit for inductive load switching and diode recovery times


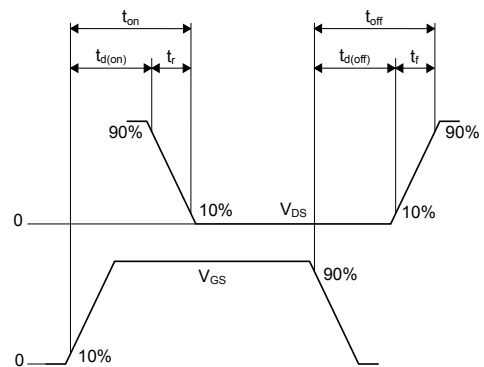
AM01470v1

Figure 16. Unclamped inductive load test circuit


AM01471v1

Figure 17. Unclamped inductive waveform


AM01472v1

Figure 18. Switching time waveform


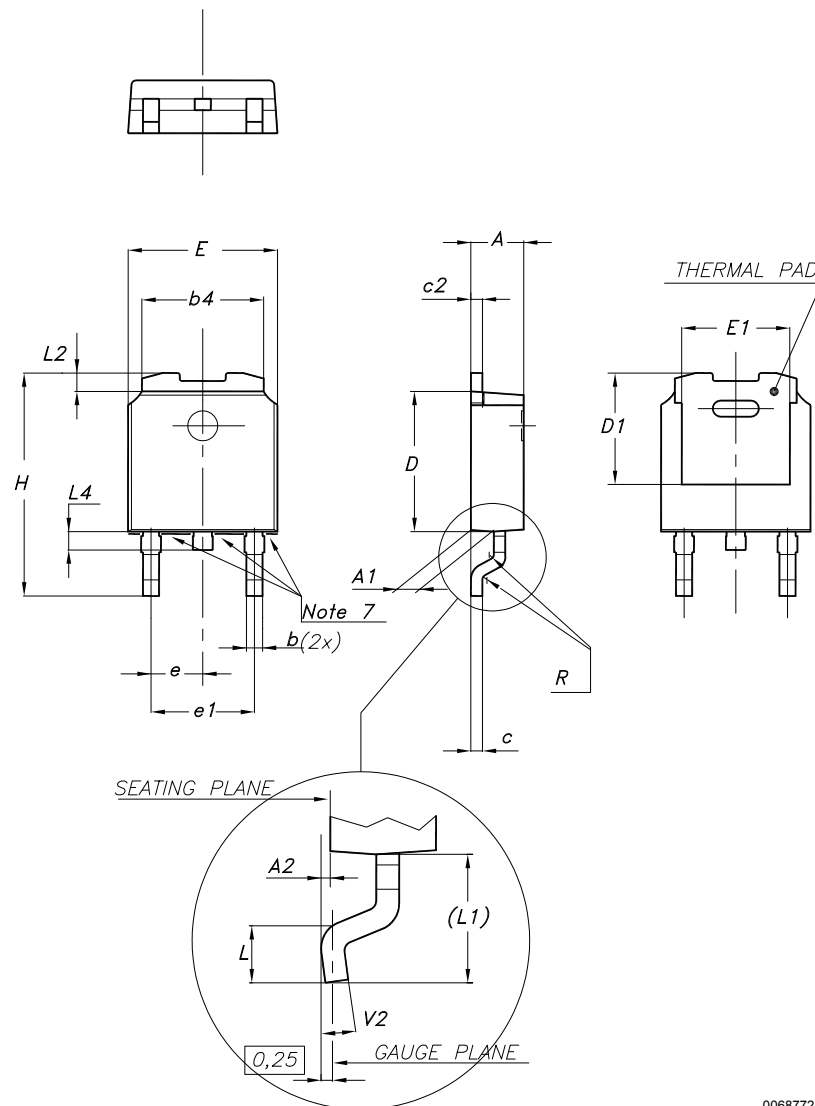
AM01473v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 DPAK (TO-252) type A2 package information

Figure 19. DPAK (TO-252) type A2 package outline

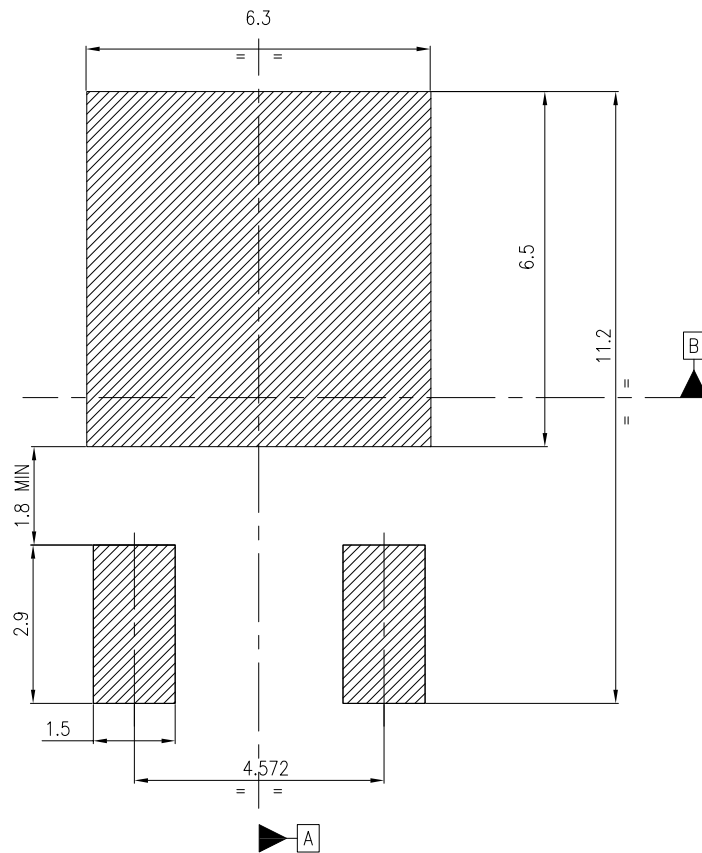


0068772_type-A2_rev34

Table 8. DPAK (TO-252) type A2 mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 2.20 | | 2.40 |
| A1 | 0.90 | | 1.10 |
| A2 | 0.03 | | 0.23 |
| b | 0.64 | | 0.90 |
| b4 | 5.20 | | 5.40 |
| c | 0.45 | | 0.60 |
| c2 | 0.48 | | 0.60 |
| D | 6.00 | | 6.20 |
| D1 | 4.95 | 5.10 | 5.25 |
| E | 6.40 | | 6.60 |
| E1 | 5.10 | 5.20 | 5.30 |
| e | 2.159 | 2.286 | 2.413 |
| e1 | 4.445 | 4.572 | 4.699 |
| H | 9.35 | | 10.10 |
| L | 1.00 | | 1.50 |
| L1 | 2.60 | 2.80 | 3.00 |
| L2 | 0.65 | 0.80 | 0.95 |
| L4 | 0.60 | | 1.00 |
| R | | 0.20 | |
| V2 | 0° | | 8° |

Figure 20. DPAK (TO-252) recommended footprint (dimensions are in mm)



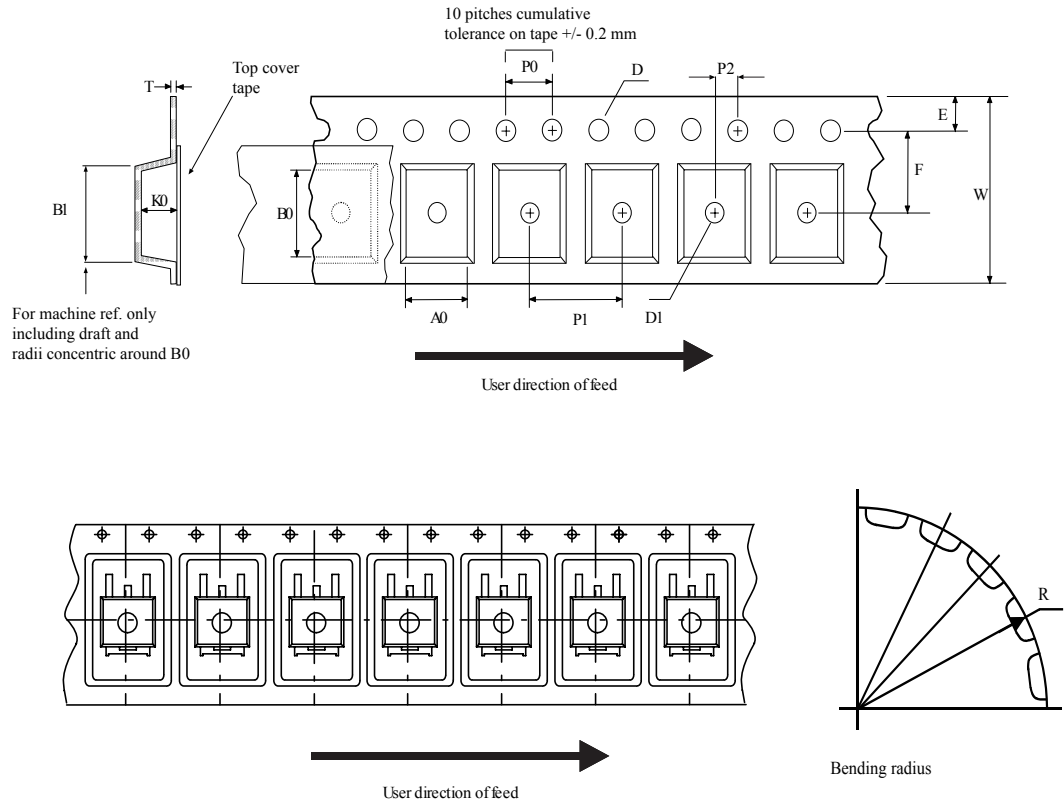
Notes:

- 1) This footprint is able to ensure insulation up to 630 Vrms (according to CEI IEC 664-1)
- 2) The device must be positioned within $\boxed{\oplus 0.05 \text{ A B}}$

FP_0068772_34

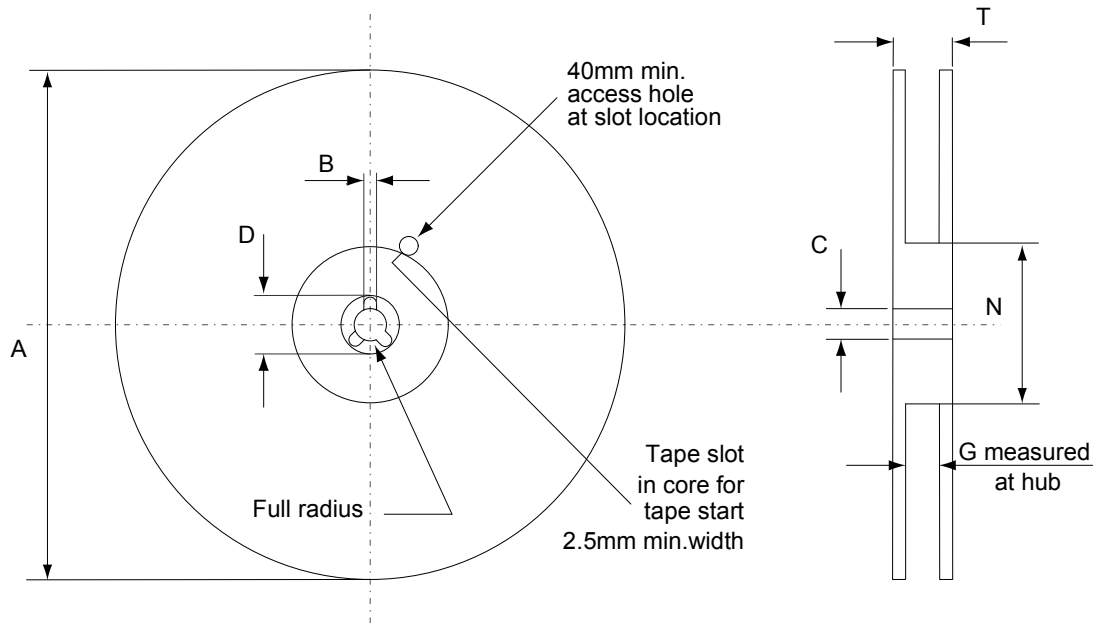
4.2 DPAK (TO-252) packing information

Figure 21. DPAK (TO-252) tape outline



AM08852v1

Figure 22. DPAK (TO-252) reel outline



AM06038v1

Table 9. DPAK (TO-252) tape and reel mechanical data

| Dim. | Tape | | Dim. | Reel | |
|------|------|------|-----------|------|------|
| | mm | | | mm | |
| | Min. | Max. | | Min. | Max. |
| A0 | 6.8 | 7 | A | | 330 |
| B0 | 10.4 | 10.6 | B | 1.5 | |
| B1 | | 12.1 | C | 12.8 | 13.2 |
| D | 1.5 | 1.6 | D | 20.2 | |
| D1 | 1.5 | | G | 16.4 | 18.4 |
| E | 1.65 | 1.85 | N | 50 | |
| F | 7.4 | 7.6 | T | | 22.4 |
| K0 | 2.55 | 2.75 | | | |
| P0 | 3.9 | 4.1 | Base qty. | | 2500 |
| P1 | 7.9 | 8.1 | Bulk qty. | | 2500 |
| P2 | 1.9 | 2.1 | | | |
| R | 40 | | | | |
| T | 0.25 | 0.35 | | | |
| W | 15.7 | 16.3 | | | |

Revision history

Table 10. Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 23-Jun-2017 | 1 | First release. |
| 16-Apr-2018 | 2 | Removed maturity status indication from cover page. The document status is production data. Modified features table on cover page. Modified <i>Table 1. Absolute maximum ratings</i> , <i>Table 3. Avalanche characteristics</i> , <i>Table 4. Static</i> , <i>Table 5. Dynamic</i> , <i>Table 6. Switching times</i> and <i>Table 7. Source-drain diode</i> . Updated <i>Section 2.1 Electrical characteristics (curves)</i> . Minor text changes. |
| 27-Jun-2018 | 3 | Updated <i>Section 4 Package information</i> . |
| 11-Nov-2019 | 4 | Updated title and features in cover page. Updated <i>Table 4. Static</i> , <i>Section 2.1 Electrical characteristics (curves)</i> and <i>Section 3 Test circuits</i> . Minor text changes. |
| 17-Jul-2023 | 5 | Updated <i>Section 4.1 DPAK (TO-252) type A2 package information</i> . Minor text changes. |

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